

**Search Notes**

Application/Control No.

10/657,199

Examiner

Susan Hanley

Applicant(s)/Patent under  
Reexamination

CHEN ET AL.

Art Unit

1651

**SEARCHED**

Class	Subclass	Date	Examiner
435	43,47, 254.11, 254.1, 254.5	6/9/2006	SMH
435	254.3	6/9/2006	SMH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN: REGISTRY, CAPLUS, see notes for search strategy	6/8/2006	SMH
WEST: USPAT, EPAB, JPAB, DWPI, PGPUBS, see notes for search strategy	6/9/2006	SMH
Inventor Search	6/9/2006	SMH